



## EMC TEST REPORT

EN 55032: 2015

EN 55020:2007/A12:2016

EN 61000-3-2: 2014

EN 61000-3-3: 2013

### MEASUREMENT AND TEST REPORT

For

Guangzhou Baolun Electronics Co., Ltd.

No.1, Building B Block, Zhongcun Street, Panyu District, Guangzhou, China

**Model:** T-200,T-200A,T-200C,T-200DW,T-200B,T-200D,T-600B,T-600W, T-400,T-800,T-600

January 25, 2019

|   |  |
|---|--|
| <b>This Report Concerns:</b>                        | <b>Equipment Type:</b>   |
| <input checked="" type="checkbox"/> Original Report | Pendant Speaker  |
| <b>Test Engineer:</b>                               | Eric/ <i>Eric</i>  |
| <b>Report Number:</b>                               | TH19AR-116E  |
| <b>Test Date:</b>                                   | January 18~25, 2019  |
| <b>Reviewed By:</b>                                 | Princel/ <i>Princel</i>  |
| <b>Approved By:</b>                                 | Princel/ <i>Princel</i>  |
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**Note:** This test report is limited to the above client company and the product model only. It may not be duplicated without prior written consent of Shenzhen Tian Hai Test Technology Co.,Ltd.



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## 1 - GENERAL INFORMATION

### 1.1 Product Description for Equipment Under Test (EUT)

#### Client Information

Applicant: **Guangzhou Baolun Electronics Co., Ltd.**  
Address: No.1, Building B Block, Zhongcun Street, Panyu District, Guangzhou, China  
Manufacturer: **Guangzhou Baolun Electronics Co., Ltd.**  
Address: No.1, Building B Block, Zhongcun Street, Panyu District, Guangzhou, China

#### General Description of E.U.T

EUT Description: **Pendant Speaker**  
Trade mark: ITC  
Model No.: T-200,T-200A,T-200C,T-200DW,T-200B,T-200D,T-600B,T-600W, T-400,T-800,T-600  
Note: All the models are similar in appearance and dimensions.  
Model T-200 was selected to do all the tests.

Remark: \* The test data gathered are from the production sample provided by the manufacturer.

### 1.2 Test Standards

The following Declaration of Conformity report of EUT is prepared in accordance with

EN 55032: 2015

EN 55020:2007/A12:2016

EN 61000-3-2: 2014

EN 61000-3-3: 2013

The objective of the manufacturer is to demonstrate compliance with the described standards above.



### 1.3 Test Summary

For the EUT described above. The standards used were EN 55032 Class B for Emissions & EN 55020 for Immunity.

Table 1 : Tests Carried Out Under EN 55032: 2015

| Standard       | Test Items  | Status |
|----------------|---|--------|
| EN 55032: 2015 | Disturbance Voltage at The Mains Terminals (0.15MHz To 30MHz) | √      |
|                | Disturbance Power (30MHz To 300MHz)                           | √      |

- √ Indicates that the test is applicable
- × Indicates that the test is not applicable

Table 2 : Tests Carried Out Under EN 61000-3-2: 2014/ EN 61000-3-3: 2013

| Standard           | Test Items                            | Status |
|--------------------|---------------------------------------|--------|
| EN 61000-3-2: 2014 | Harmonic Current Test                 | √      |
| EN 61000-3-3: 2013 | Voltage Fluctuations and Flicker Test | √      |

- √ Indicates that the test is applicable
- × Indicates that the test is not applicable

Table 3 : Tests Carried Out Under EN 55032: 2015

| Standard                              | Test Items  | Status |
|---------------------------------------|---|--------|
| EN61000-4-2:2009                      | Electrostatic discharge Immunity                  | √      |
| EN 61000-4-3:2006+A1:2008<br>+A2:2010 | Radiated Susceptibility (80MHz to 1GHz)           | √      |
| EN 61000-4-4:2012                     | Electrical Fast Transient/Burst Immunity          | √      |
| EN 61000-4-5:2014/A1:2017             | Surge Immunity                                    | √      |
| EN 61000-4-6:2014/AC:2015             | Conducted Susceptibility (150kHz to 80MHz)        | √      |
| EN61000-4-8:2010                      | Power Frequency Magnetic Field Immunity (50/60Hz) | ×      |
| EN 61000-4-11:2004/A1:2017            | Voltage Dips, Short Interruptions Immunity        | √      |

- √ Indicates that the test is applicable
- × Indicates that the test is not applicable

### 1.4 Test Methodology

All measurements contained in this report were conducted with CISPR 32, radio disturbance and immunity measuring apparatus, and CISPR 32, Method of measurement of disturbances and immunity





1.5 Test Equipment List and Details

| No. | Equipment                                | Manufacturer    | Model No.                  | S/N                | Calculator date | Calculator due date |
|-----|--|-----------------|----------------------------|--------------------|-----------------|---------------------|
| 1   | EMI Test Receiver                        | R&S             | ESCI                       | 100687             | 2018-03-16      | 2019-03-15          |
| 2   | EMI Test Receiver                        | R&S             | ESPI                       | 100097             | 2018-03-16      | 2019-03-15          |
| 3   | Amplifier                                | HP              | 8447D                      | 1937A0249<br>2     | 2018-03-16      | 2019-03-15          |
| 4   | Single Power Conductor Module            | FCC             | FCC-LISN-5-50-1-01-CISPR25 | 7101               | 2018-03-16      | 2019-03-15          |
| 5   | Single Power Conductor Module            | FCC             | FCC-LISN-5-50-1-01-CISPR25 | 7102               | 2018-03-16      | 2019-03-15          |
| 6   | Power Clamp                              | SCHWARZ BECK    | MDS-21                     | 3812               | 2018-03-16      | 2019-03-15          |
| 7   | Positioning Controller                   | C&C             | CC-C-1F                    | MF780211<br>3      | N/A             | N/A                 |
| 8   | Electrostatic Discharge Simulator        | TESEQ           | NSG437                     | 125                | 2018-03-16      | 2019-03-15          |
| 9   | Fast Transient Burst Generator           | SCHAFFNER       | MODULA6150                 | 34572              | 2018-03-16      | 2019-03-15          |
| 10  | Fast Transient Noise Simulator           | Noiseken        | FNS-105AX                  | 31485              | 2018-03-16      | 2019-03-15          |
| 11  | Color TV Pattern Genenerator             | PHILIPS         | PM5418                     | TM209947           | N/A             | N/A                 |
| 12  | Power Frequency Magnetic Field Generator | EVERFINE        | EMS61000-8K                | 608002             | 2018-03-16      | 2019-03-15          |
| 13  | Capacitive Coupling Clamp                | TESEQ           | CDN8014                    | 25096              | 2018-03-16      | 2019-03-15          |
| 14  | High Field Biconical Antenna             | ELECTRO-METRICS | EM-6913                    | 166                | 2018-03-16      | 2019-03-15          |
| 15  | Log Periodic Antenna                     | ELECTRO-METRICS | EM-6950                    | 811                | 2018-03-16      | 2019-03-15          |
| 16  | Remote Active Vertical Antenna           | ELECTRO-METRICS | EM-6892                    | 304                | 2018-03-16      | 2019-03-15          |
| 17  | TRILOG Broadband Test-Antenna            | SCHWARZ BECK    | VULB9163                   | 9163-324           | 2018-03-16      | 2019-03-15          |
| 18  | Horn Antenna                             | SCHWARZ BECK    | BBHA9120A                  | B08000991<br>-0001 | 2018-03-16      | 2019-03-15          |
| 19  | Teo Line Single Phase Module             | SCHWARZ BECK    | NSLK8128                   | D-69250            | 2018-03-16      | 2019-03-15          |
| 20  | Electricity bridge                       | Zentech         | 100 LCR METER              | 803024             | 2018-03-16      | 2019-03-15          |
| 21  | RF Current Probe                         | FCC             | F-33-4                     | 80                 | N/A             | N/A                 |
| 22  | Signal Generator                         | HP              | 8647A                      | 3349A0229<br>6     | 2018-03-16      | 2019-03-15          |
| 23  | Microwave Amplifier                      | HP              | 8349B                      | 2627A0099<br>4     | 2018-03-16      | 2019-03-15          |
| 24  | Triple-Loop Antenna                      | EVERFINE        | LLA-2                      | 607004             | 2018-03-16      | 2019-03-15          |



## 2 - SYSTEM TEST CONFIGURATION

### 2.1 Justification

The system was configured for testing in a typical fashion (as normally used by a typical user).

### 2.2 EUT Exercise Software

The EUT exercising program used during radiated and conducted testing was designed to exercise the various system components in a manner similar to a typical use. The software offered by manufacturer, can let the EUT being normal operation.

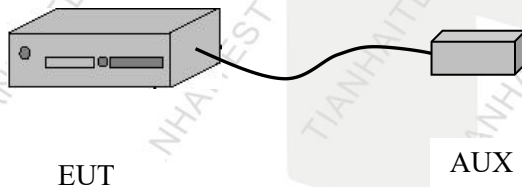
### 2.3 Special Accessories

As shown in section 2.5, interface cable used for compliance testing is shielded as normally supplied by manufacturer and its respective support equipment manufacturers.

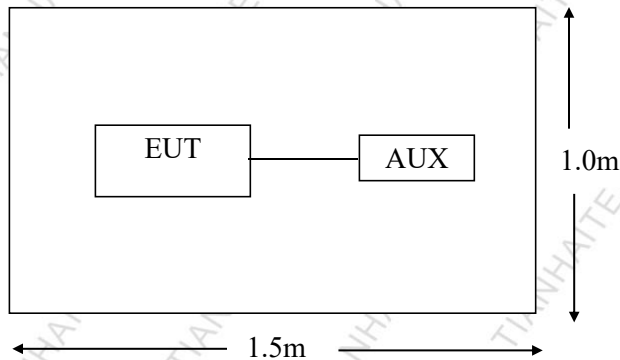
### 2.4 Basic Configuration of Test System

Emission: The equipment under test (EUT) was configured to measure its highest possible radiation level. The test modes were adapted accordingly in reference to the Operating Instructions.

Immunity: The equipment under test (EUT) was configured to the representative operating mode and conditions.



### 2.5 Test Setup Diagram





### 3 - DISTURBANCE VOLTAGE AT THE MAINS TERMINALS

#### 3.1 Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, and LISN.

The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of any conducted emissions measurement is 3.4 dB.

#### 3.2 Limit of Disturbance Voltage At The Mains Terminals (Class B)

| Frequency Range (MHz) | Limits ( dBuV) |         |
|-----------------------|----------------|---------|
|                       | Quasi-Peak     | Average |
| 0.150~0.500           | 66~56          | 56~46   |
| 0.500~5.000           | 56             | 46      |
| 5.000~30.00           | 60             | 50      |

Note: (1)The tighter limit shall apply at the edge between two frequency bands.

#### 3.3 EUT Setup

The setup of EUT is according with CISPR 32 measurement procedure. The specification used was the EN 55032 limits.

The EUT was placed center and the back edge of the test table.

The AV cables were draped along the test table and bundled to 30-40cm in the middle.

The spacing between the peripherals was 10 cm.

Maximum emission emitted from EUT was determined by manipulating the EUT, support equipment, interconnecting cables and varying the mode of operation and the levels in the final result of the test were recorded with the EUT running in the operating mode that maximum emission was emitted.

#### 3.4 Instrument Setup

The test receiver was set with the following configurations:

Test Receiver Setting:

Frequency Range.....150 KHz to 30 MHz  
 Detector.....Peak & Quasi-Peak & Average  
 Sweep Speed.....Auto  
 IF Band Width.....9 KHz





### 3.5 Test Procedure

During the conducted emission test, the EUT power cord was connected to the auxiliary outlet of the first Artificial Mains.

Maximizing procedure was performed on the six (6) highest emissions to ensure EUT compliance using all installation combination.

All data was recorded in the peak detection mode. Quasi-peak and Average readings were only performed when an emission was found to be marginal (within  $-10 \text{ dB}_{\mu\text{V}}$  of specification limits). Quasi-peak readings are distinguished with a "QP". Average readings are distinguished with a "AV".

### 3.6 Summary of Test Results

According to the data in section 3.6, the EUT complied with the EN 55032 Conducted margin, which represented the worst margin reading.

### 3.7 Disturbance Voltage Test Data

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

Test data see following pages

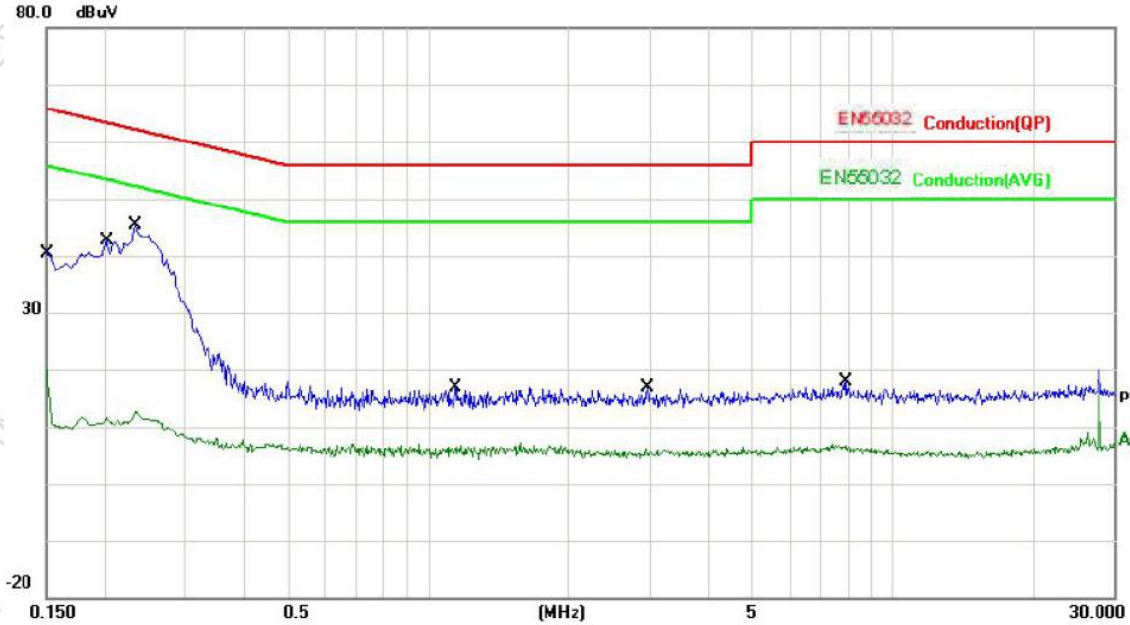
### 3.8 Test Result

**PASS**



Disturbance Voltage Test Data

EUT: Pendant Speaker M/N: T-200  
 Operating Condition: ON  
 Test Site: Shielded Room  
 Operator: Eric  
 Comment: Live Line Tem:24°C Hum:60%

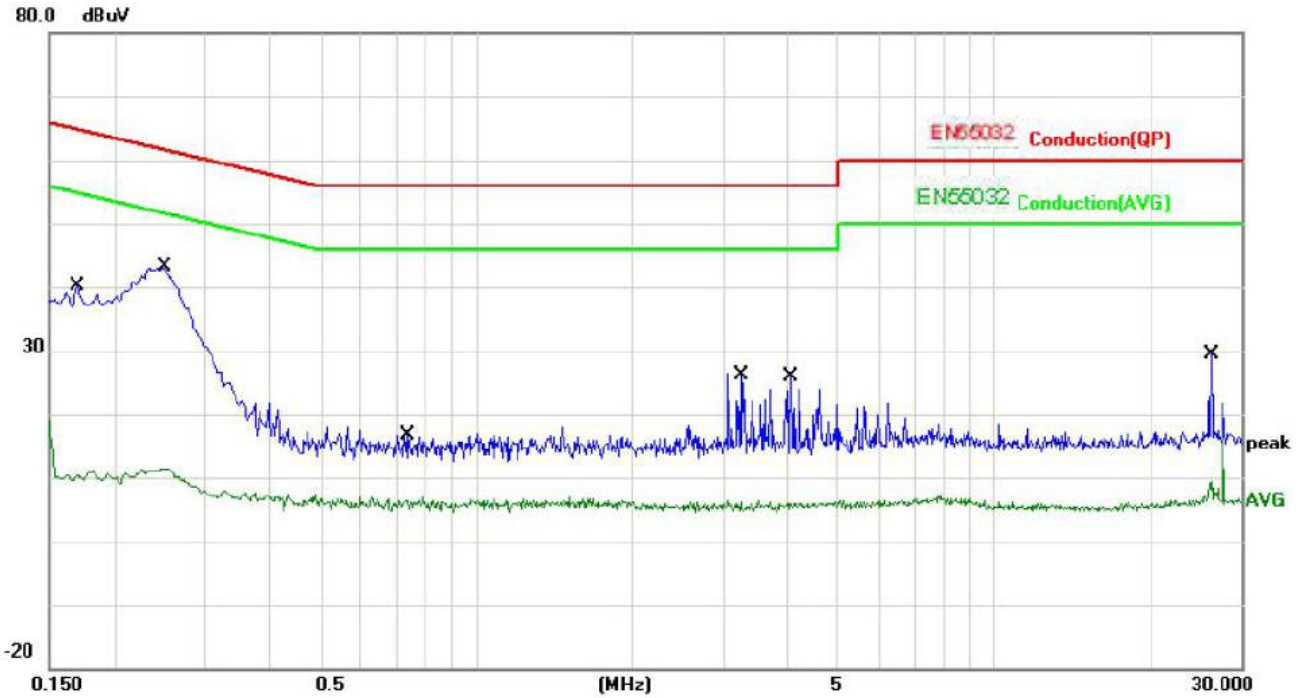


| No. | Frequency (MHz) | Factor (dB) | Reading (dBuV) | Level (dBuV) | Limit (dBuV) | Margin (dB) | Detector |
|-----|-----------------|-------------|----------------|--------------|--------------|-------------|----------|
| 1   | 0.1500          | 9.78        | 23.02          | 32.80        | 66.00        | -33.20      | QP       |
| 2   | 0.1500          | 9.78        | 7.73           | 17.51        | 56.00        | -38.49      | AVG      |
| 3   | 0.2020          | 9.78        | 23.66          | 33.44        | 63.53        | -30.09      | QP       |
| 4   | 0.2020          | 9.78        | 0.51           | 10.29        | 53.53        | -43.24      | AVG      |
| 5   | 0.2340          | 9.78        | 26.98          | 36.76        | 62.31        | -25.55      | QP       |
| 6   | 0.2340          | 9.78        | 1.55           | 11.33        | 52.31        | -40.98      | AVG      |
| 7   | 1.1420          | 9.83        | -1.09          | 8.74         | 56.00        | -47.26      | QP       |
| 8   | 1.1420          | 9.83        | -4.14          | 5.69         | 46.00        | -40.31      | AVG      |
| 9   | 2.9660          | 9.89        | -0.25          | 9.64         | 56.00        | -46.36      | QP       |
| 10  | 2.9660          | 9.89        | -5.03          | 4.86         | 46.00        | -41.14      | AVG      |
| 11  | 7.9580          | 9.88        | 0.70           | 10.58        | 60.00        | -49.42      | QP       |
| 12  | 7.9580          | 9.88        | -4.11          | 5.77         | 50.00        | -44.23      | AVG      |



Disturbance Voltage Test Data

EUT: Pendant Speaker M/N: T-200  
 Operating Condition: ON  
 Test Site: Shielded Room  
 Operator: Eric  
 Comment: Neutral Line Tem:24°C Hum:60%



| No. | Frequency (MHz) | Factor (dB) | Reading (dBuV) | Level (dBuV) | Limit (dBuV) | Margin (dB) | Detector |
|-----|-----------------|-------------|----------------|--------------|--------------|-------------|----------|
| 1   | 0.1700          | 9.78        | 19.95          | 29.73        | 64.96        | -35.23      | QP       |
| 2   | 0.1700          | 9.78        | -0.18          | 9.60         | 54.96        | -45.36      | AVG      |
| 3   | 0.2500          | 9.78        | 25.66          | 35.44        | 61.76        | -26.32      | QP       |
| 4   | 0.2500          | 9.78        | 1.07           | 10.85        | 51.76        | -40.91      | AVG      |
| 5   | 0.7420          | 9.84        | -0.77          | 9.07         | 56.00        | -46.93      | QP       |
| 6   | 0.7420          | 9.84        | -4.01          | 5.83         | 46.00        | -40.17      | AVG      |
| 7   | 3.2500          | 9.89        | -0.19          | 9.70         | 56.00        | -46.30      | QP       |
| 8   | 3.2500          | 9.89        | -5.02          | 4.87         | 46.00        | -41.13      | AVG      |
| 9   | 4.0580          | 9.90        | -0.41          | 9.49         | 56.00        | -46.51      | QP       |
| 10  | 4.0580          | 9.90        | -5.03          | 4.87         | 46.00        | -41.13      | AVG      |
| 11  | 26.2900         | 10.07       | 3.11           | 13.18        | 60.00        | -46.82      | QP       |
| 12  | 26.2900         | 10.07       | -1.75          | 8.32         | 50.00        | -41.68      | AVG      |





## 4 - DISTURBANCE POWER

### 4.1 Limit of Disturbance Power

| Frequency Range (MHz) | Limit (dBpW) |         |
|-----------------------|--------------|---------|
|                       | Quasi-Peak   | Average |
| 30~300                | 45~55        | 35~45   |

Note: (1) The limit line is a linear line.

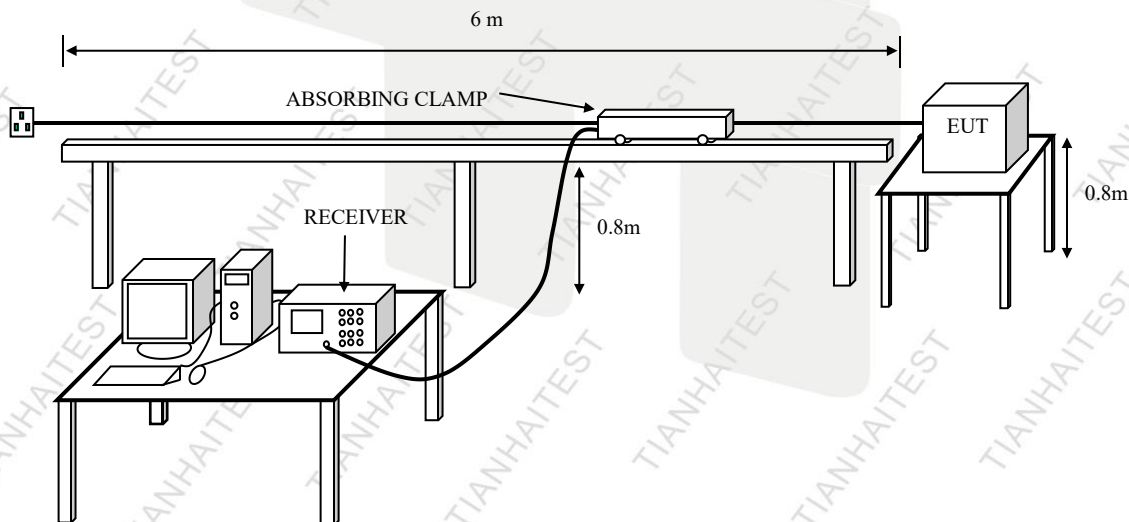
### 4.2 EUT Setup

The setup of EUT is according with CISPR 32 measurement procedure. See following test setup figure. The specification used was the EN 55032 limits.

The EUT was placed at the edge of the test table so as to make the end of the lead close to the EUT as short as possible between the power clamp and the EUT.

The spacing between the peripherals was 10 cm.

Maximum emission emitted from EUT was determined by manipulating the EUT, support equipment, interconnecting cables and varying the mode of operation and the levels in the final result of the test were recorded with the EUT running in the operating mode that maximum emission was emitted.





### 4.3 Instruments Setup

The test receiver was set with the following configurations:

Test Receiver Setting:

Frequency Range.....30 MHz to 300 MHz  
 Detector.....Peak & Quasi-Peak & Average  
 Sweep Speed.....Auto  
 IF Band Width.....9 KHz

### 4.4 Test Procedure

The associated equipment under test is placed on a non-metallic table of 0.8 m of height above the floor and at least 0.4 m from other objects and from any person. The lead to be measured shall be stretched in a straight horizontal line for a length sufficient to accommodate the absorbing clamp and to permit the necessary adjustment of its position for tuning. The absorbing clamp is placed around the lead to be measured, with its current transformer towards the equipment under test, so as to measure a quantity proportional to the disturbance power on the lead.

Any other lead less than that to be measured shall either be disconnected, if mechanically and functionally possible, or fitted with ferrite rings to attenuate RF currents which may affect the measurement results. Such a lead shall be stretched away from the connected unit in a direction perpendicular to the direction of the lead to be measured.

All connectors not used shall be left un-terminated. All connectors having a connected lead shall be terminated in a manner representative of use. If the leads are screened and normally terminated in a screened unit, then the termination shall be screened.

### 4.5 Disturbance Power Test Data

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

### 4.6 Test Plot(s) for Disturbance Power

Plot(s) of Conducted Emissions Test Data is presented hereinafter as reference.

### 4.7 Test Result

**PASS**



Disturbance Power Test Data

EUT: Pendant Speaker M/N: T-200
Operating Condition: ON
Operator: Eric
Comment: AC Line Tem:24°C Hum:60%

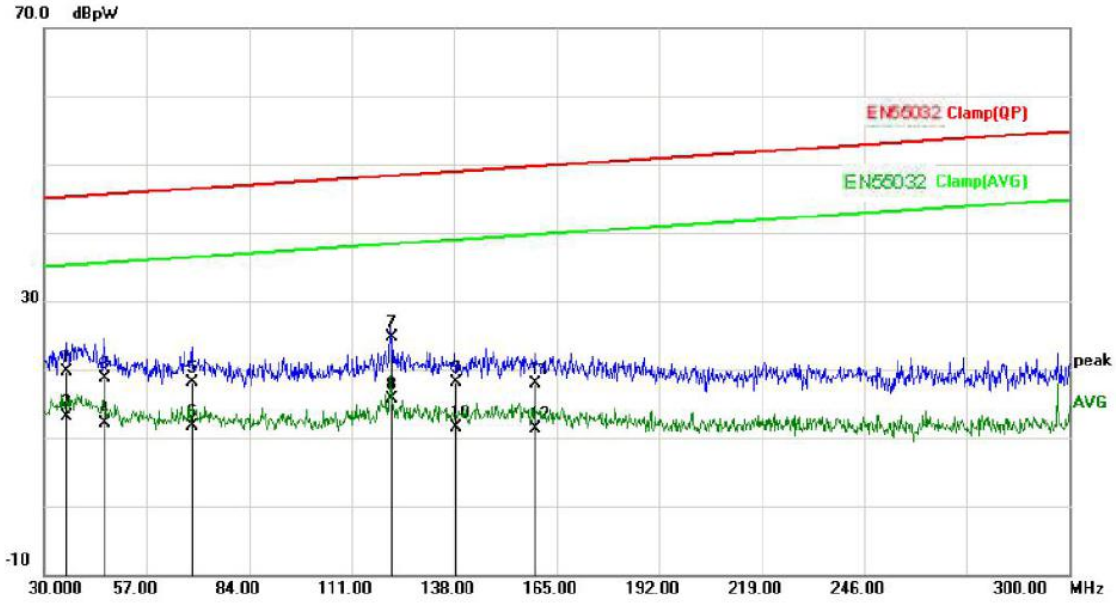


Table with 8 columns: No., Frequency (MHz), Factor (dB), Reading (dBUV), Level (dBUV), Limit (dBUV), Margin (dB), Detector. It lists 12 test results for various frequencies and their corresponding levels and margins.





## 5 - HARMONIC CURRENT TEST (EN 61000-3-2)

### 5.1 Application of Harmonic Current Emission

Compliance to these standards ensures that tested equipment will not generate harmonic currents at levels that cause unacceptable degradation of the main environment. This directly contributes to meeting compatibility levels established in other EMC standards, which defines compatibility levels for low-frequency conducted disturbances in low-voltage supply systems.

### 5.2 Measurement Data

Note: For detailed test data, refer to the following pages:

|                   |  |
|-------------------|--|
| Standard used:    | EN/IEC 61000-3-2 A14 (2006) Quasi-stationary - Equipment class A |
| Observation time: | 150s   |
| E. U. T           | Pendant Speaker  |
| M/N               | T-200  |
| Operation Mode    | N/A  |

### 5.3 Test Results

This EUT is deemed to comply with the requirements of EN 61000-3-2: 2014 without test since the power of EUT is less than 75W.



## 6 - VOLTAGE FLUCTUATIONS AND FLICKER TEST (EN 61000-3-3)

### 6.1 Application of Voltage Fluctuations and Flicker Test

Compliance to these standards ensures that tested equipment will not generate flickers and voltage change at levels that cause unacceptable degradation of the main environment. This directly contributes to meeting compatibility levels established in other EMC standards, which defines compatibility levels for low-frequency conducted disturbances in low-voltage supply systems.

### 6.2 Measurement Data

Note: For detailed test data, refer to the following pages:

|                   |                                |
|-------------------|--------------------------------|
| Standard used:    | EN/IEC 61000-3-3 Flicker       |
| Short time (Pst): | 10 min                         |
| Observation time: | 10 min (1 Flicker measurement) |
| Flickermeter:     | 230V/50Hz                      |
| E. U. T.:         | Pendant Speaker                |
| M/N               | T-200                          |
| Operation Mode    | ON                             |

Test Result : PASS

### Maximum Flicker results

|          | EUT values | Limit | Result |
|----------|------------|-------|--------|
| Pst      | 0.030      | 1.00  | PASS   |
| dc [%]   | 0.027      | 3.30  | PASS   |
| dmax [%] | 0.025      | 4.00  | PASS   |
| dt [s]   | 0.000      | 0.50  | PASS   |

### 6.3 Test Results

The EUT was subjected to the voltage fluctuations and flicker test required by EN 61000-3-3: 2013.



## **7 - EN 55020 TEST PROCEDURES**

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### **7.1 Electrostatic Discharge Test System**

An EM TEST DITOC0103Z ESD simulator is used for all testing. It is capable of applying Electrostatic discharges in both contact discharge modes to 4 kV and air discharge modes to 8 kV in both positive and negative polarities. This is in accordance with the IEC 61000-4-2 basic EMC publication.

### **7.2 Radiated Susceptibility Test System**

An IFR 2032 signal generator and a Amplifier Research Pendant Speaker are used to provide a signal at the appropriate power and frequency to a transmitting antenna to obtain the required electromagnetic field at the position of the EUT in accordance with the IEC 61000-4-3 basic EMC publication. The field was monitored by Amplifier Research field probe and Amplifier Research PM2002 power meter according the IEC 61000-4-3 standards. In order to judge the performance of the EUT, a set of monitor system is used.

### **7.3 Electrical Fast Transient/Burst Immunity Test System**

An EM Test UCS 500-M6 Immunity test system is used for all testing. It is capable of applying fast transients to the AC line at any phase angle with respect to the AC line voltage wave form and to attached cables via a capacitive coupling clamp in accordance with the IEC 61000-4-4 basic EMC publication.

### **7.4 Surge Immunity Test System**

An EM Test UCS 500-M6 Immunity test system is used for all testing. Both positive and negative polarities of voltage up to 2kV were applied to the AC input lines. The coupling network defined in the standard was used.

### **7.5 Conducted Susceptibility Test System**

An IFR 2032A signal generator and a set of Amplifier Research test system are used for the testing. EUT was tested from 0.15 MHz to 80 MHz with 1kHz sine wave, 80% modulation with 3Vr.m.s. CDN coupling and de-coupling networks and EM clamp was tested. During the tests, injected was applied to power line by using CDNs-6.2.2 method, and I/O lines was injected by using EM clamp injection-6.2.3.method.

### **7.6 Power Frequency Magnetic Field Immunity Test System**

An EM Test UCS 500-M6 Immunity test system is used for all testing. Test level as described in IEC 61000-4-8 titled "Table 1 – Test Levels for continuous field" was chosen. Single turn induction coil in 1m x 1m size was used to generate the magnetic field.

### **7.7 Voltage Dips, Short Interruptions Immunity Tests System**

An EM Test UCS 500-M6 Immunity test system is used for all testing. Test level as described in IEC 61000-4-11, section 5, titled "Test Levels".





## 7.8 Equipment Test Table

IEC 61000-4-2: 1995 specifies that a tabletop EUT shall be placed on a non-conducting table which is 80 centimeters above a ground reference plane and that floor mounted equipment shall be placed on a insulating support approximately 10 centimeters above a ground plane. During the tests, the EUT is positioned over a ground reference plane in conformance with this requirement.

For tabletop equipment, a 1.6 by 0.8-meter metal sheet (HCP) is placed on the table and connected to the ground plane via a metal strap with two 470 k Ohms resistors in series. The EUT and attached cables are isolated from this metal sheet by 0.5-millimeter thick insulating material. A Vertical Coupling Plane (VCP) grounded on the ground plane through the same configuration as in the HCP is used.

IEC 61000-4-3 and IEC 61000-4-4 specify that a tabletop EUT be placed on a non-conducting table 80 centimeters above a ground reference plane and that floor-mounted equipment shall be placed on an insulating support approximately 10 centimeters above a ground plane. During the IEC 61000-4-3 tests, the EUT is positioned on a table in a shielded semi-anechoic test chamber to reduce reflections from the internal surfaces of the chamber. During the IEC 61000-4-4 tests, the EUT is positioned on a table over a ground reference plane in conformance with this requirement.

## 7.9 Instrument Calibration

All test equipment is regularly checked to ensure that performance is maintained in accordance with the manufacturer's specifications.

Extensive engineering efforts have been made to ensure test data reliability through Quality Control and regular equipment calibration schedules. However, the application of radio frequency fields and voltages are not without an unavoidable level of uncertainty. These include inaccuracies in antenna factors, chamber imperfections and possible test generator output uncertainties.



## **8 - EN 55020 TEST PROCEDURES**

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### **8.1 EUT and Cable Placement**

The EUT and any peripherals are located at the center of the table for tabletop devices and in the center of the ground plane with the insulating support for floor-standing devices. The standards require that interconnecting cables to be connected to available ports of the unit and that the placement of the unit and the attached cables simulate a typical installation so far as to be practical.

### **8.2 Application of Electrostatic Discharge Immunity Test**

The test is conducted in the following order according to the basic standard IEC 61000-4-2: Air Discharge, Direct Contact Discharge, Indirect Contact Horizontal Coupling Plane Discharge, and Indirect Contact Vertical Coupling Plane Discharge. The Electrostatic Discharge test levels are set and discharges for the different test modes are set appropriately. The Electrostatic Discharge is applied to the conductive surface of the computer in which the EUT is enclosed, and along all seams and control surfaces on the computer. When a discharge occurs and an error is caused, the type of error, discharge level and location is recorded.

### **8.3 Application of Radiated Susceptibility Test**

The electromagnetic field is established at the front edge of the EUT. The frequency range is swept from 80 to 1000 MHz using a power level necessary to obtain a 3 volt/meter and 80% amplitude of a 1 kHz sine wave modulated field Strength is directed at the EUT. The test is performed with each of four sides of EUT facing the transmitting antenna. If an error is detected when the susceptible side of the EUT facing the transmitting antenna, the field is reduced until the error is not repeatable, the field is then manually increased until the error begins to occur. This threshold level, the frequency and the error created are noted before continuing. Both horizontal and vertical polarization of the antenna are set on test and measured individually

### **8.4 Application of Electrical Fast Transient/Burst Immunity Test**

The EUT was arranged for Power Line Coupling and for I/O Line Coupling through a capacitive clamp, where applicable. (Note: The I/O coupling test using a capacitive clamp is performed on the I/O interface cables that are longer in length than 3 meters.) A metal ground plane 2.4 meter by 2.0 meter was placed between the floor and the table and is connected to the earth by a 2.0 meter ground rod. The ground rod is connected to the test facility's electrical earth.

### **8.5 Application of Surge Immunity Test**

The EUT was setup as described in IEC 61000-4-5 and the test shall be performed according to the test plan.

### **8.6 Application of Conducted Susceptibility Test**

The EUT was setup according to the IEC 61000-4-6 and the test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF input ports of the coupling devices are terminated by a 50  $\Omega$  load resistor. The frequency range is 150kHz to 80 MHz.



### **8.7 Application of Power Frequency Magnetic Field Immunity Test**

It is deemed that according to the standard of EN55032 this test is not applicable to the EUT which dose not contain devices susceptible to magnetic fields, such as CRT monitors, Hall elements, electro-dynamic microphone, magnetic field sensor, etc.

### **8.8 Application of Voltage Dips, Short Interruptions Immunity Tests**

The EUT was setup according to the IEC 61000-4-11 and the test shall be done as the procedure described in the standard.

### **8.9 Deviations from the Standard**

No deviations from EN 55020 were made when performing the tests described in this report.





## 9 - TEST DATA

### 9.1 Electrostatic Discharge Immunity Test (IEC 61000-4-2)

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

Table 1: Electrostatic Discharge Immunity (Air Discharge)

| IEC 61000-4-2 Test Points | Test Levels |       |       |       |       |       |       |       |        |        |
|---------------------------|-------------|-------|-------|-------|-------|-------|-------|-------|--------|--------|
|                           | -2 kV       | +2 kV | -4 kV | +4 kV | -6 kV | +6 kV | -8 kV | +8 kV | -15 kV | +15 kV |
| Slot                      | A           | A     | A     | A     | A     | A     | A     | A     | /      | /      |

Table 2: Electrostatic Discharge Immunity (Direct Contact)

| IEC 61000-4-2 Test Points | Test Levels |       |       |       |       |       |       |       |        |        |
|---------------------------|-------------|-------|-------|-------|-------|-------|-------|-------|--------|--------|
|                           | -2 kV       | +2 kV | -4 kV | +4 kV | -6 kV | +6 kV | -8 kV | +8 kV | -15 kV | +15 kV |
| Screws                    | A           | A     | A     | A     | /     | /     | /     | /     | /      | /      |

Table 3: Electrostatic Discharge Immunity (Indirect Contact HCP)

| IEC 61000-4-2 Test Points | Test Levels |       |       |       |       |       |       |       |        |        |
|---------------------------|-------------|-------|-------|-------|-------|-------|-------|-------|--------|--------|
|                           | -2 kV       | +2 kV | -4 kV | +4 kV | -6 kV | +6 kV | -8 kV | +8 kV | -15 kV | +15 kV |
| HCP                       | A           | A     | A     | A     | /     | /     | /     | /     | /      | /      |

Table 4: Electrostatic Discharge Immunity (Indirect Contact VCP)

| IEC 61000-4-2 Test Points | Test Levels |       |       |       |       |       |       |       |        |        |
|---------------------------|-------------|-------|-------|-------|-------|-------|-------|-------|--------|--------|
|                           | -2 kV       | +2 kV | -4 kV | +4 kV | -6 kV | +6 kV | -8 kV | +8 kV | -15 kV | +15 kV |
| Front Side                | A           | A     | A     | A     | /     | /     | /     | /     | /      | /      |
| Back Side                 | A           | A     | A     | A     | /     | /     | /     | /     | /      | /      |
| Left Side                 | A           | A     | A     | A     | /     | /     | /     | /     | /      | /      |
| Right Side                | A           | A     | A     | A     | /     | /     | /     | /     | /      | /      |



### 9.2 Radiated Susceptibility Test (IEC 61000-4-3)

**Frequency Range (MHz):** 80~1000MHz  
**Modulation:** Amplitude 80%, 1kHz sinewave  
**Severity Level:** 3V/m

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

| Frequency Range (MHz) | Front (3 V/m) |      | Rear (3 V/m) |      | Left Side (3 V/m) |      | Right Side (3 V/m) |      |
|-----------------------|---------------|------|--------------|------|-------------------|------|--------------------|------|
|                       | VERT          | HORI | VERT         | HORI | VERT              | HORI | VERT               | HORI |
| 80-1000<br>1400-2700  | A             | A    | A            | A    | A                 | A    | A                  | A    |

### 9.3 Electrical Fast Transient/Burst Immunity Test (IEC 61000-4-4)

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

| IEC 61000-4-4 Test Points |            | Test Levels (kV) |      |      |      |      |      |      |      |
|---------------------------|------------|------------------|------|------|------|------|------|------|------|
|                           |            | +0.5             | -0.5 | +1.0 | -1.0 | +2.0 | -2.0 | +4.0 | -4.0 |
| Power Supply              | L          | A                | A    | A    | A    | /    | /    | /    | /    |
|                           | N          | A                | A    | A    | A    | /    | /    | /    | /    |
|                           | PE         | /                | /    | /    | /    | /    | /    | /    | /    |
|                           | L+N        | A                | A    | A    | A    | /    | /    | /    | /    |
| Power Line of EUT         | L + PE     | /                | /    | /    | /    | /    | /    | /    | /    |
|                           | N + PE     | /                | /    | /    | /    | /    | /    | /    | /    |
|                           | L + N + PE | /                | /    | /    | /    | /    | /    | /    | /    |
|                           |            | /                | /    | /    | /    | /    | /    | /    | /    |



### 9.4 Surge Immunity Test (IEC 61000-4-5)

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

Table 1: Surge Power Supply

| Level | Voltage | Poll | Path            | Pass | Fail |
|-------|---------|------|-----------------|------|------|
| 1     | 0.5kV   | ±    | L-N             | A    | /    |
| 2     | 1kV     | ±    | L-N             | A    | /    |
| 3     | 2kV     | ±    | L-PE, N-PE      | /    | /    |
| 4     | 4kV     | ±    | L-N, L-PE, N-PE | /    | /    |

### 9.5 Conducted Susceptibility Test (IEC 61000-4-6)

**Frequency Range (MHz):** 0.15~80MHz  
**Modulation:** Amplitude 80%, 1kHz sinewave  
**Severity Level:** 3Vr.m.s.

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

| Level | Voltage Level (e.m.f.)<br>U <sub>0</sub> | Pass | Fail |
|-------|--|------|------|
| 1     | 1  | /    | /    |
| 2     | 3  | A    | /    |
| 3     | 10                                       | /    | /    |
| X     | Special                                  | /    | /    |





### 9.6 Voltage Dips, Short Interruptions Immunity Tests (IEC 61000-4-11)

|                              |                 |
|------------------------------|-----------------|
| Temperature ( °C )           | 15~35           |
| Humidity ( %RH )             | 30~60           |
| Barometric Pressure ( mbar ) | 860~1060        |
| EUT                          | Pendant Speaker |
| M/N                          | T-200           |
| Operating Mode               | ON              |

| Level | U2   | td     | Phase Angle  | N | Pass | Fail |
|-------|------|--------|--------------|---|------|------|
| 1     | >95% | 10ms   | 0/90/180/270 | 3 | B    | /    |
| 2     | 30%  | 500ms  | N/A          | 3 | C    | /    |
| 3     | >95% | 5000ms | N/A          | 3 | C    | /    |

Note:

- A. The apparatus shall continue to operate as intended during and after the test. The manufacturer specifies some minimum performance level. The performance level may be specified by the manufacturer as a permissible loss of performance.
- B. The apparatus shall continue to operate as intended after the test. This indicates that the EUT does not need to function at normal performance levels during the test, but must recover. Again some minimal performance is defined by the manufacture. No change in operating state or loss or data is permitted.
- C. Temporary loss of function is allowed. Operation of the EUT may stop as long as it is either automatically reset or can be manually restored by operation of the controls.



## 10 - TEST RESULTS

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The following tests were performed on the EUT; the actual test results are contained within the Test Data section of this report.

### 10.1 IEC 61000-4-2 Electrostatic Discharge Immunity Test Configuration

The EUT was subjected to the electrostatic discharge tests required by EN 55020 and all lower levels specified in IEC 61000-4-2.

*The EUT continued to perform as intended during and after the application of the ESD.*

### 10.2 IEC 61000-4-3 Radiated Susceptibility Test Configuration

The EUT was subjected to a 3-volt/meter, 80% Amplitude, 1 kHz Sine wave field as required by EN 55020 and all lower levels specified in IEC 61000-4-3.

*The EUT continued to perform as intended during and after the application of the electromagnetic field.*

### 10.3 IEC 61000-4-4 Electrical Fast Transient/Burst Immunity Test Configuration

The EUT was subjected to the electrical fast transient tests required by EN 55020 and all lower levels specified in IEC 61000-4-4.

*The EUT continued to perform as intended during and after the application of the EFT/B.*

### 10.4 IEC 61000-4-5 Surge Immunity Test Configuration

The EUT was subjected to the Surge Immunity tests required by EN 55020 and all lower levels specified in IEC 61000-4-5.

*The EUT continued to perform as intended during and after the application of the Surge Immunity Test.*

### 10.5 IEC 61000-4-6 Conducted Susceptibility Test Configuration

The EUT was subjected to the Conducted Susceptibility tests required by EN 55020 and all lower levels specified in IEC 61000-4-6.

*The EUT continued to perform as intended during and after the application of the Conducted Susceptibility Test.*

### 10.6 IEC 61000-4-11 Voltage Dips, Short Interruptions Immunity Tests Configuration

The EUT was subjected to the Voltage Dips/Interruptions tests required by EN 55020 and all lower levels specified in IEC 61000-4-11.

*The EUT continued to perform as intended during and after the application of the Voltage Dips/Interruptions Test.*



## APPENDIX A - PRODUCT LABELING

### CE Marking Label Specification

Specification: Text is Black or white in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT or silk-screened onto the EUT.

### Proposed Label Location on EUT

EUT Rear View/Proposed CE Marking Location







**APPENDIX B - EUT PHOTOGRAPHS**









**APPENDIX C - TEST SETUP PHOTOGRAPHS**



\*\*\*\*\*END OF THE REPORT\*\*\*\*\*